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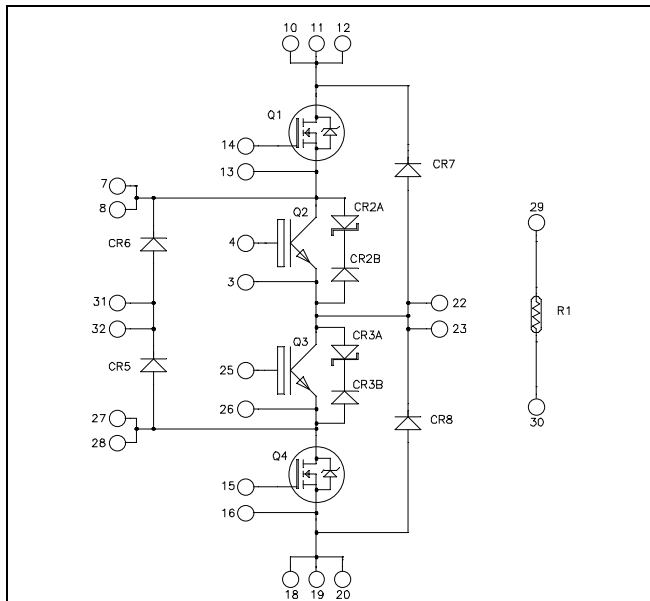
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Three level inverter Power Module

Trench & Field Stop IGBT4 Q2, Q3:
 $V_{CES} = 1200V$; $I_C = 40A$ @ $T_c = 80^\circ C$

Super junction MOSFET Q1, Q4:
 $V_{DSS} = 900V$; $I_D = 23A$ @ $T_c = 80^\circ C$

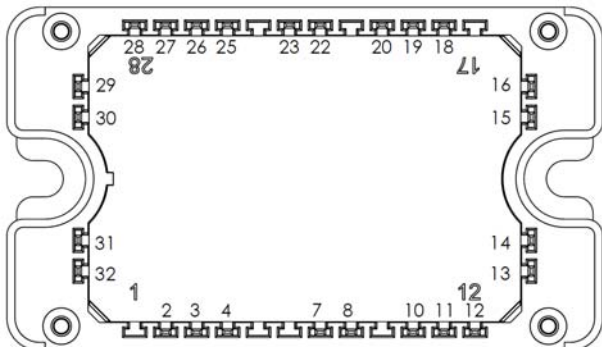


Application

- Solar converter
- Uninterruptible Power Supplies

Features

- **Q2, Q3 Trench + Field Stop IGBT 4**
 - Low voltage drop
 - Low leakage current
 - Low switching losses
- **Q1, Q4 Super junction MOSFET**
 - Ultra low R_{DSon}
 - Low Miller capacitance
 - Ultra low gate charge
 - Avalanche energy rated
 - Very rugged
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring



All multiple inputs and outputs must be shorted together
 Example: 10/11/12 ; 7/8 ...

Benefits

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Low profile
- RoHS Compliant

All ratings @ $T_j = 25^\circ C$ unless otherwise specified

 **CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

Q1 & Q4 Absolute maximum ratings (per Super junction MOSFET)

<i>Symbol</i>	<i>Parameter</i>	<i>Max ratings</i>	<i>Unit</i>
V_{DS}	Drain - Source Voltage	900	V
I_D	Continuous Drain Current	$T_c = 25^\circ\text{C}$	A
		$T_c = 80^\circ\text{C}$	
I_{DM}	Pulsed Drain current	75	
V_{GS}	Gate - Source Voltage	± 20	V
$R_{DS(on)}$	Drain - Source ON Resistance	120	m Ω
P_D	Power Dissipation	$T_c = 25^\circ\text{C}$	W
I_{AR}	Avalanche current (repetitive and non repetitive)	8.8	A
E_{AR}	Repetitive Avalanche Energy	2.9	mJ
E_{AS}	Single Pulse Avalanche Energy	1940	

Q1 & Q4 Electrical Characteristics (per Super junction MOSFET)

<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>	<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 900V$			100	μA
$R_{DS(on)}$	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 26A$		100	120	m Ω
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 3mA$	2.5	3	3.5	V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			100	nA

Q1 & Q4 Dynamic Characteristics (per Super junction MOSFET)

<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>	<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
C_{iss}	Input Capacitance	$V_{GS} = 0V; V_{DS} = 100V$ $f = 1MHz$		6800		pF
C_{oss}	Output Capacitance			330		
Q_g	Total gate Charge	$V_{GS} = 10V$ $V_{Bus} = 400V$ $I_D = 26A$		270		nC
Q_{gs}	Gate – Source Charge			32		
Q_{gd}	Gate – Drain Charge			115		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C) $V_{GS} = 10V$ $V_{Bus} = 400V$ $I_D = 26A$ $R_G = 7.5\Omega$		70		ns
T_r	Rise Time			20		
$T_{d(off)}$	Turn-off Delay Time			400		
T_f	Fall Time			25		
R_{thJC}	Junction to Case Thermal resistance				0.5	$^\circ\text{C/W}$

Q2 & Q3 Absolute maximum ratings (per IGBT)

<i>Symbol</i>	<i>Parameter</i>	<i>Max ratings</i>	<i>Unit</i>
V_{CES}	Collector - Emitter Voltage	1200	V
I_C	Continuous Collector Current	$T_c = 25^\circ\text{C}$	A
		$T_c = 80^\circ\text{C}$	
I_{CM}	Pulsed Collector Current	$T_c = 25^\circ\text{C}$	70
V_{GE}	Gate – Emitter Voltage	± 20	V
P_D	Power Dissipation	$T_c = 25^\circ\text{C}$	220
RBSOA	Reverse Bias Safe Operating Area	$T_j = 150^\circ\text{C}$	70A @ 1100V

Q2 & Q3 Electrical Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I _{CES}	Zero Gate Voltage Collector Current	V _{GE} = 0V, V _{CE} = 1200V			250	μA
V _{CE(sat)}	Collector Emitter saturation Voltage	V _{GE} = 15V I _C = 35A		1.85 2.25	2.25	V
V _{GE(th)}	Gate Threshold Voltage	V _{GE} = V _{CE} , I _C = 1.2mA	5.0	5.8	6.5	V
I _{GES}	Gate – Emitter Leakage Current	V _{GE} = 20V, V _{CE} = 0V			400	nA

Q2 & Q3 Dynamic Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C _{ies}	Input Capacitance	V _{GE} = 0V V _{CE} = 25V f = 1MHz		1950		pF
C _{oes}	Output Capacitance			155		
C _{res}	Reverse Transfer Capacitance			115		
Q _G	Gate charge	V _{GE} = ±15V ; V _{CE} = 600V I _C = 35A		0.27		μC
T _{d(on)}	Turn-on Delay Time	Inductive Switching (25°C) V _{GE} = ±15V V _{CE} = 600V I _C = 35A R _G = 12Ω		130		ns
T _r	Rise Time			20		
T _{d(off)}	Turn-off Delay Time			300		
T _f	Fall Time			45		
T _{d(on)}	Turn-on Delay Time	Inductive Switching (150°C) V _{GE} = ±15V V _{CE} = 600V I _C = 35A R _G = 12Ω		150		ns
T _r	Rise Time			35		
T _{d(off)}	Turn-off Delay Time			350		
T _f	Fall Time			80		
E _{on}	Turn-on Switching Energy	V _{GE} = ±15V V _{CE} = 600V		2.6 4		mJ
E _{off}	Turn-off Switching Energy	I _C = 35A R _G = 12Ω		2 3		
I _{sc}	Short Circuit data	V _{GE} ≤ 15V ; V _{Bus} = 900V t _p ≤ 10μs ; T _j = 150°C		140		A
R _{thJC}	Junction to Case Thermal Resistance				0.68	°C/W

CR2 & CR3 diode ratings and characteristics (per device)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V _F	Diode + tranzorb Forward Voltage	I _F = 10A		10.5		V
R _{thJC}	Junction to Case Thermal Resistance				8	°C/W

CR5 & CR6 diode ratings and characteristics (per diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V _{RRM}	Peak Repetitive Reverse Voltage					1000	V
I _{RM}	Reverse Leakage Current	V _R =1000V				100	μA
I _F	DC Forward Current		T _c = 80°C		40		A
V _F	Diode Forward Voltage	I _F = 40A			2.5	3	V
		I _F = 80A			3.1		
		I _F = 40A	T _j = 125°C		2		
t _{rr}	Reverse Recovery Time	I _F = 40A V _R = 667V di/dt = 200A/μs	T _j = 25°C		250		ns
			T _j = 125°C		315		
Q _{rr}	Reverse Recovery Charge		T _j = 25°C		415		nC
			T _j = 125°C		1650		
E _{rr}	Reverse Recovery Energy	I _F = 40A V _R = 667V di/dt = 1000A/μs	T _j = 125°C		1.3		mJ
R _{thJC}	Junction to Case Thermal Resistance					1.2	°C/W

CR7 & CR8 diode ratings and characteristics (per diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V _{RRM}	Peak Repetitive Reverse Voltage					1200	V
I _{RM}	Reverse Leakage Current	V _R =1200V				100	μA
I _F	DC Forward Current		T _c = 80°C		40		A
V _F	Diode Forward Voltage	I _F = 30A			2.6	3.1	V
		I _F = 60A			3.2		
		I _F = 30A	T _j = 125°C		1.8		
t _{rr}	Reverse Recovery Time	I _F = 30A V _R = 800V di/dt = 200A/μs	T _j = 25°C		300		ns
			T _j = 125°C		380		
Q _{rr}	Reverse Recovery Charge		T _j = 25°C		360		nC
			T _j = 125°C		1700		
E _{rr}	Reverse Recovery Energy	I _F = 30A V _R = 800V di/dt = 1000A/μs	T _j = 125°C		1.6		mJ
R _{thJC}	Junction to Case Thermal Resistance					1.2	°C/W

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C		50		kΩ
ΔR ₂₅ /R ₂₅			5		%
B _{25/85}	T ₂₅ = 298.15 K		3952		K
ΔB/B			4		%

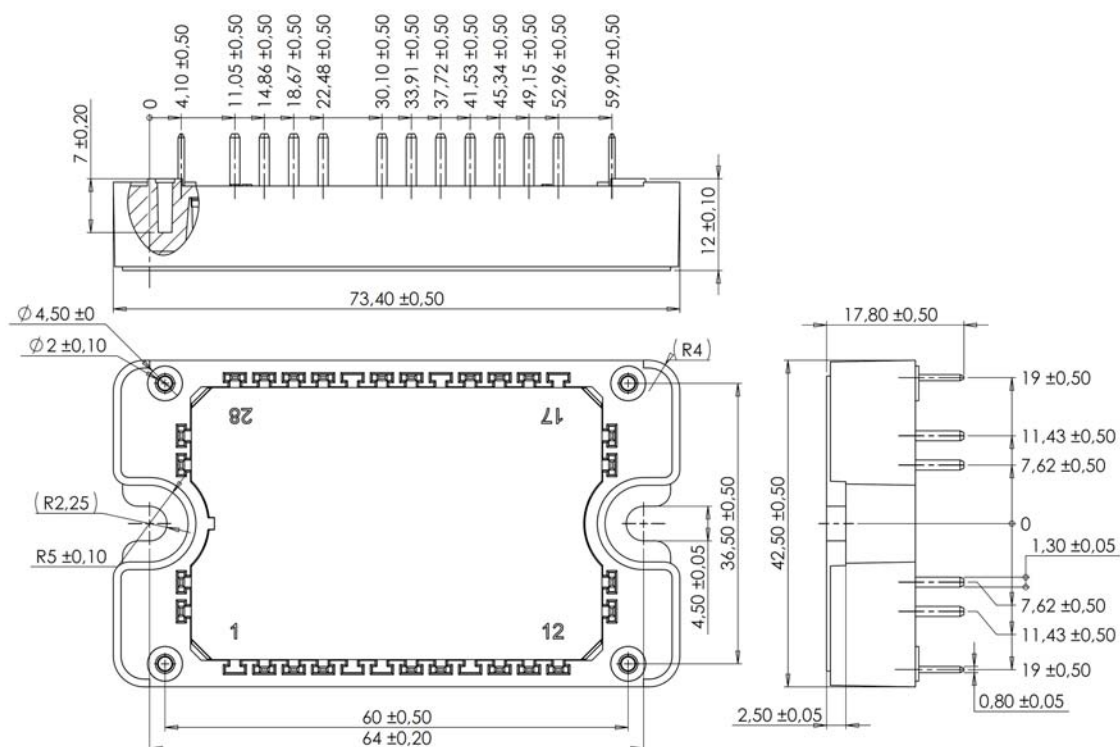
$$R_T = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{25}} - \frac{1}{T} \right) \right]}$$

T: Thermistor temperature
 R_T: Thermistor value at T

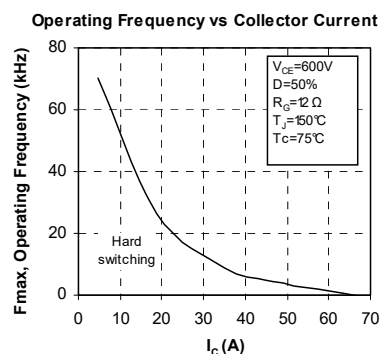
Thermal and package characteristics

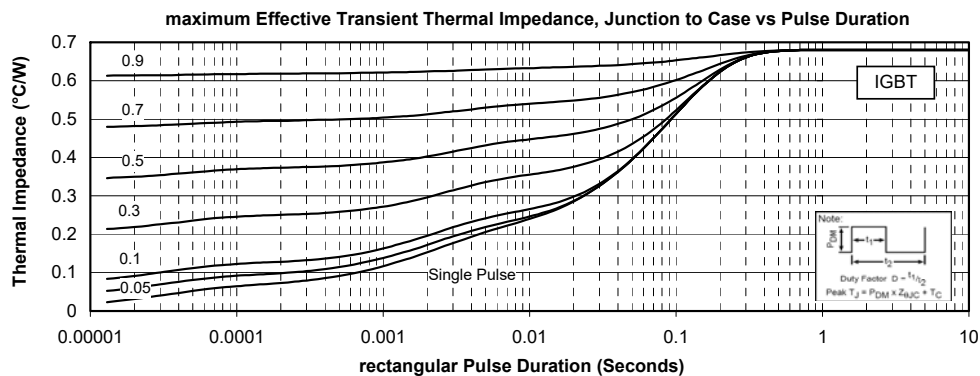
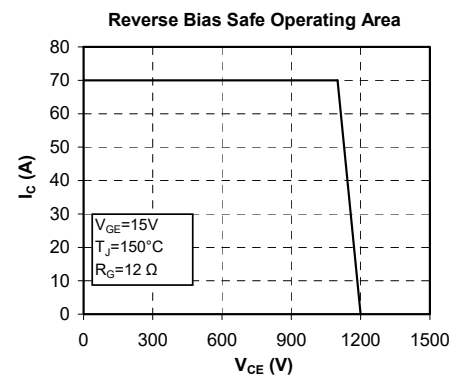
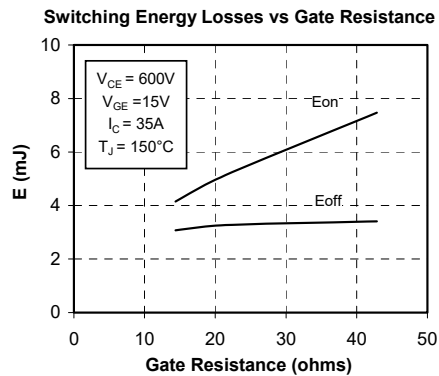
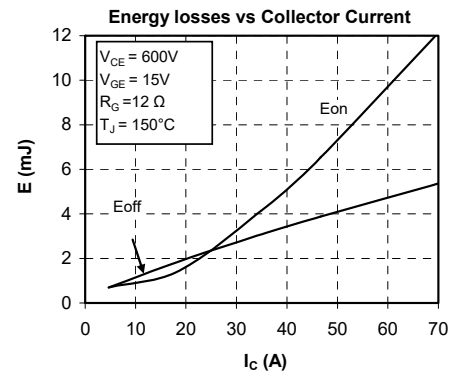
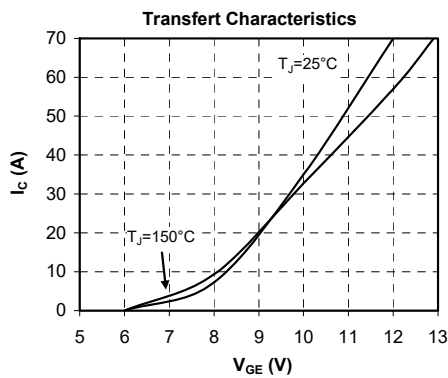
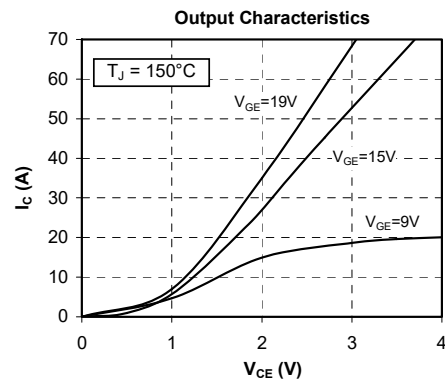
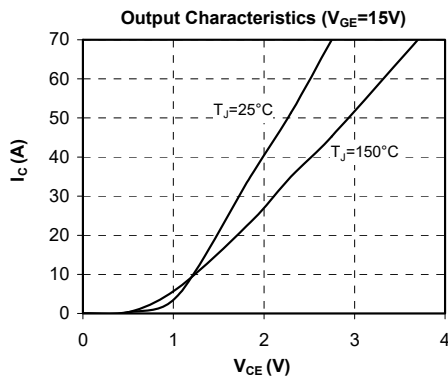
Symbol	Characteristic	Min	Max	Unit
V _{ISOL}	RMS Isolation Voltage, any terminal to case t=1 min, 50/60Hz	4000		V
T _J	Operating junction temperature range	-40	175*	°C
T _{JOP}	Recommended junction temperature under switching conditions	-40	T _{Jmax} -25	
T _{STG}	Storage Temperature Range	-40	125	
T _C	Operating Case Temperature	-40	125	
Torque	Mounting torque	To heatsink	M4	N.m
Wt	Package Weight		110	g

* T_{Jmax} = 150°C for Q1 & Q4

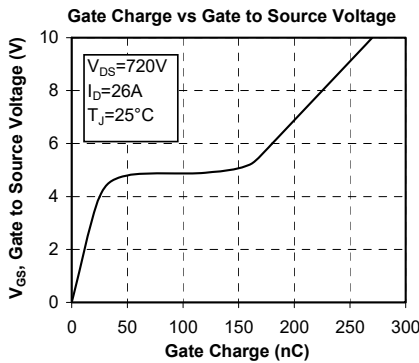
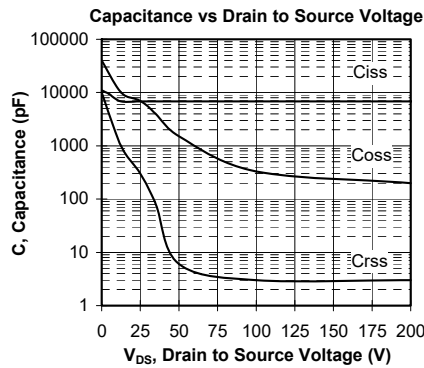
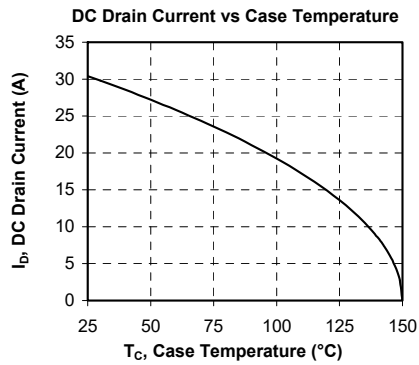
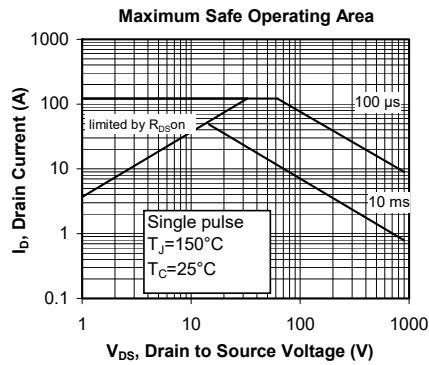
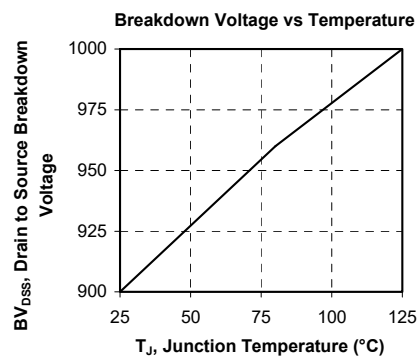
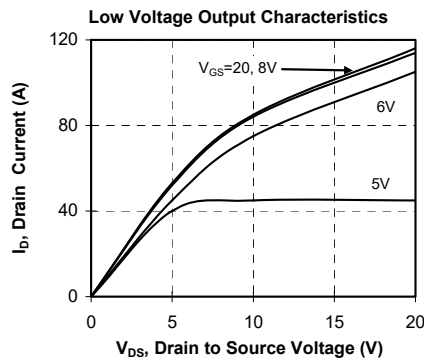
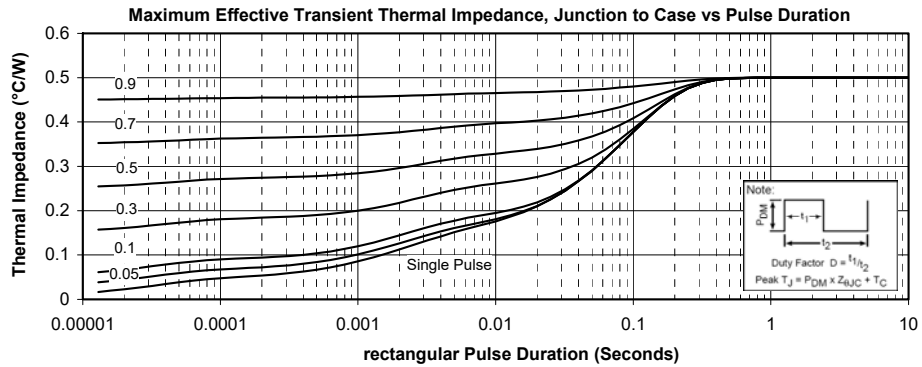
Package outline (dimensions in mm)


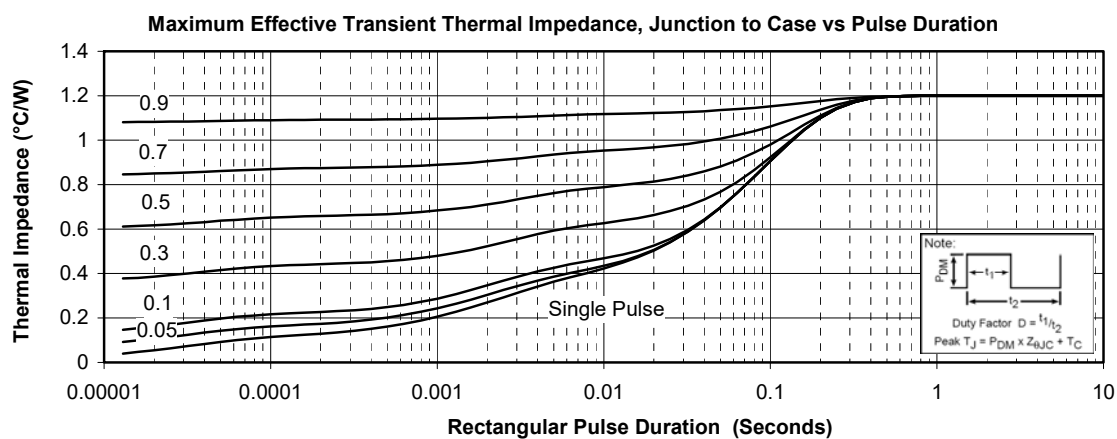
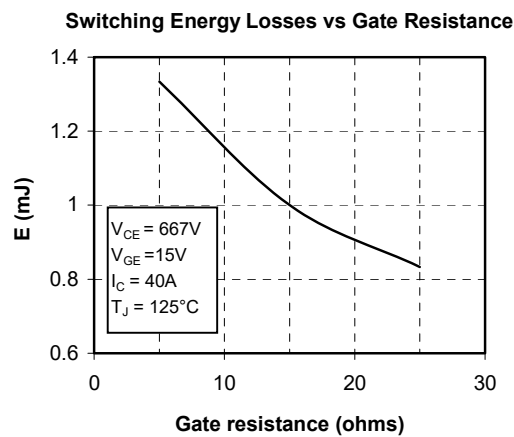
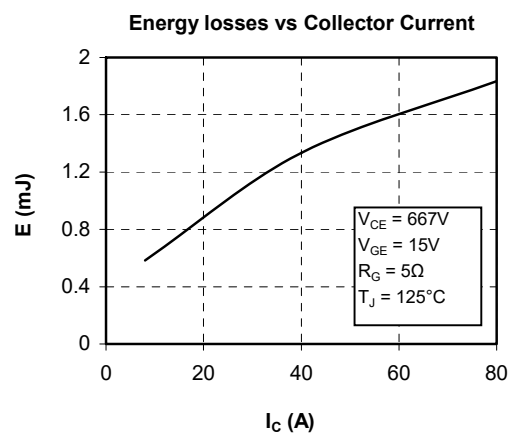
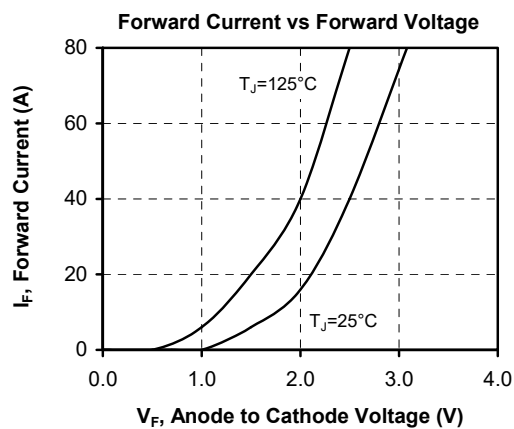
See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

Q2 & Q3 Typical performance curve


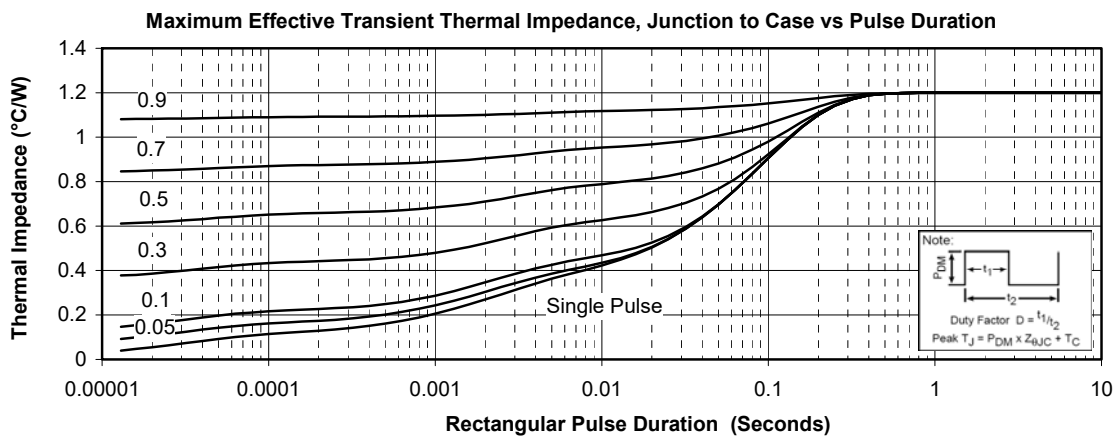
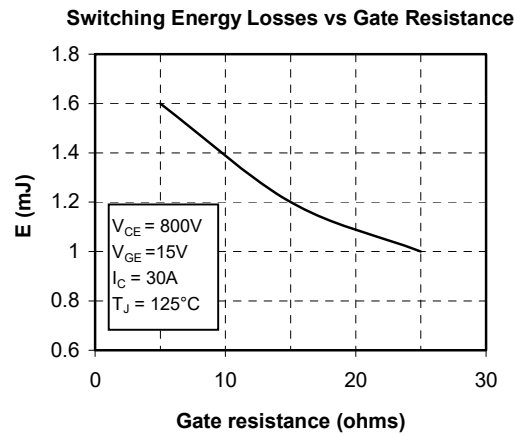
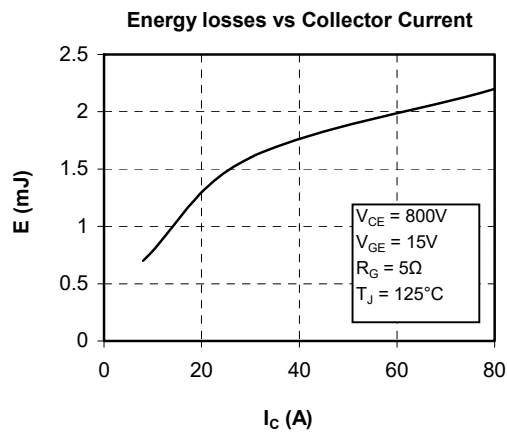
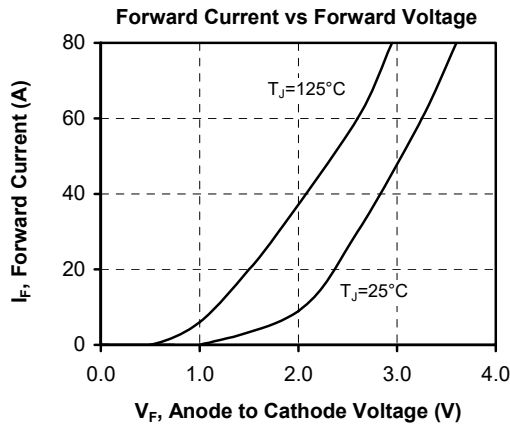


Q1 & Q4 Typical performance curve



CR5 & CR6 Typical performance curve


CR7 & CR8 Typical performance curve



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